

FORM PTO-1449  
(MODIFIED)

SEP 22 2003

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.

KCC-1162

SERIAL NO.

10/036,864

LIST OF PRIOR ART CITED BY APPLICANT  
(Use several sheets if necessary)

APPLICANT(S)

Sridhar RANGANATHAN et al.

FILING DATE

21 December 2001

GROUP

1746

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SEP 23 2003

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## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
EE	AL	WO 99/63923	12/1999	PCT				
	AM	EP 1 029 886 A2	08/2000	Europe				
	AN	WO 00/69383	11/2000	PCT				
EE	AO	WO 02/077347 A2	10/2002	PCT				
	AP	WO 02/076520 A2	10/2002	PCT				

## OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EE	AR	Derwent Abstract; XP 002240906 & KR 8 901 835 B; 05/25/89
EE	AS	Patent Abstracts of Japan; 1/21/94 & JP 05 263318 A; 10/12/93
EE	AT	Bronkhorst et al.: Deformation and Failure Behavior of Paper, Handbook of Physical Testing of Paper, pp. 313-349, Volume 1, 2002

EXAMINER

Eligible MDE

DATE CONSIDERED

9/16/04

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

KCC-1162

USCOMM-DC 80-3985

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U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.

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SERIAL NO.

10/036,842

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APPLICANT(S)

Sridhar RANGANATHAN et al.

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**U.S. PATENT DOCUMENTS**

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
EC	AA	4,756,969	07/1988	Takeda			
	AB	5,246,770	09/1993	Bottiglione et al.			
	AC	5,418,045	05/1995	Pike et al.			
	AD	5,858,535	01/1999	Wang et al.			
EC	AE	6,214,274	04/2001	Melius et al.			
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**FOREIGN PATENT DOCUMENTS**

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
EC	AL	GB 2 196 343 A	04/1988	Great Britain				
	AM	EP 0 540 041 B1	05/1993	Europe				
	AN	WO 96/14885	05/1996	PCT				
	AO	WO 97/27884	08/1997	PCT				
EC	AP	WO 98/48857	11/1998	PCT				

**OTHER PRIOR ART** (Including Author, Title, Date, Pertinent Pages, Etc.)

EC	AR	Cavlin et al.: A New Method for Measuring the Edgewise Compression Properties of Paper, Svensk Papperstidning, No. 9, pp. 330-332, 1975
EC	AS	Derwent Abstract; XP 002240776 & JP 58 019360 A; 02/04/83
EC	AT	Derwent Abstract; XP 002240768 & JP 61 055249 A; 03/19/86

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Elizabeth M. Olop

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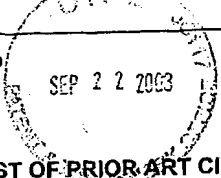
2/11/02

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	APPLICANT(S) Sridhar RANGANATHAN et al.			
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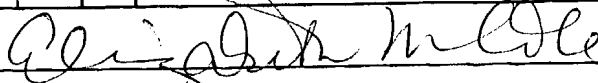
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	AL							
	AM							
	AN							
	AO							
	AP							

## OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

	AR	Fellers et al.: <u>Edgewise Compression Strength of Paper</u> , <u>Handbook of Physical Testing of Paper</u> , pp. 481-503, Volume 1, 2002
	AS	
	AT	

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